

<b>Notice of References Cited</b>	Application/Control No. 10/529,300		Applicant(s)/Patent Under Reexamination KONNO ET AL.	
	Examiner Phung T. Nguyen		Art Unit 2612	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,798,337	09-2004	Onuma et al.	340/5.72
	B	US-6,944,528	09-2005	Nagano, Tetsuji	701/49
	C	US-6,946,949	09-2005	Heide et al.	340/5.61
	D	US-6,188,141	02-2001	Daviaud, Yves	307/10.5
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.